

Search Notes

Application/Control No.

10/632,475

Examiner

Truc T. T. Nguyen

Applicant(s)/Patent under
Reexamination

LEE ET AL.

Art Unit

2833

SEARCHED

Class	Subclass	Date	Examiner
439	636-637 62-65 660	5/10/2005	TN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
same as searched above		5/10/05	

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR